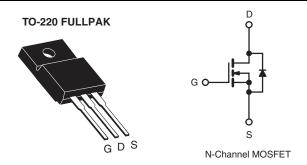


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	200			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.40		
Q _g (Max.) (nC)	43			
Q _{gs} (nC)	7.0			
Q _{gd} (nC)	23			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)



COMPLIANT

0

- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION			
Package	TO-220 FULLPAK		
Lead (Pb)-free	IRFI630GPbF		
Lead (PD)-liee	SiHFI630G-E3		
SnPb	IRFI630G		
SIFD	SiHFI630G		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	200	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	1-	5.9	А	
	VGS at 10 V	T _C = 100 °C	ID	3.7		
Pulsed Drain Current ^a			I _{DM}	24		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	230	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.9	Α	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	35	W	
Peak Diode Recovery dV/dtc			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10	S		300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 9.9 mH, $R_G = 25$ Ω , $I_{AS} = 5.9$ A (see fig. 12).
- c. $I_{SD} \le 5.9$ A, $dI/dt \le 120$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI630G, SiHFI630G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		·					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	200	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.24	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zara Cata Valtaga Duain Occupant		V _{DS} =	V _{DS} = 200 V, V _{GS} = 0 V		-	25	ι. Λ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.5 A ^b	-	-	0.40	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	V _{DS} = 50 V, I _D = 3.5 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	800	-	-
Output Capacitance	C _{oss}			-	240	-	
Reverse Transfer Capacitance	C _{rss}			-	76	-	pF
Drain to Sink Capacitance	С			-	12	-	
Total Gate Charge	Qg		I _D = 5.9 A, V _{DS} = 160 V, see fig. 6 and 13 ^b	-	-	43	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	7.0	
Gate-Drain Charge	Q _{gd}	1		-	-	23	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 100 \text{ V}, I_D = 5.9 \text{ A},$ $R_G = 12 \Omega, R_D = 16 \Omega,$ see fig. 10^b		-	9.4	-	- ns
Rise Time	t _r			-	28	-	
Turn-Off Delay Time	t _{d(off)}			-	39	-	
Fall Time	t _f			-	20	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal Source Inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.9	- А
Pulsed Diode Forward Current ^a	I _{SM}			-	-	24	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 5.9 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		_	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 5.9 A, dI/dt = 100 A/μs ^b		-	170	340	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.1	2.2	μC
Forward Turn-On Time	t _{on}	Intrinsic to	on is don	on is dominated by L _S and L _D)			

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

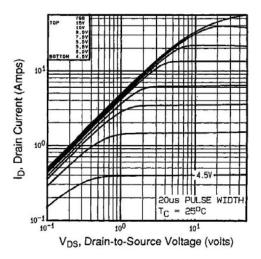
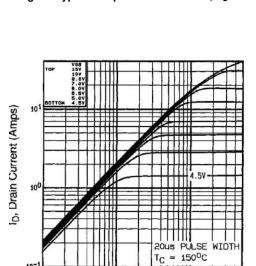


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C



 V_{DS} , Drain-to-Source Voltage (volts) Fig. 2 - Typical Output Characteristics, T_C = 150 °C

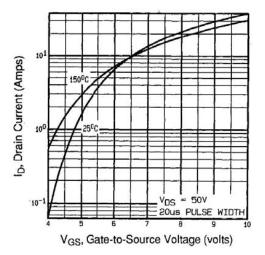


Fig. 3 - Typical Transfer Characteristics

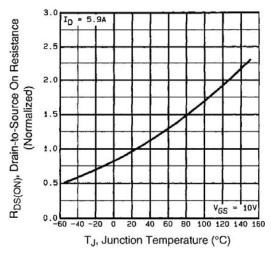


Fig. 4 - Normalized On-Resistance vs. Temperature

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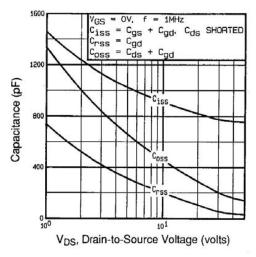


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

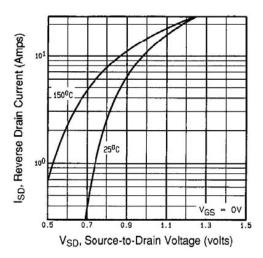


Fig. 7 - Typical Source-Drain Diode Forward Voltage

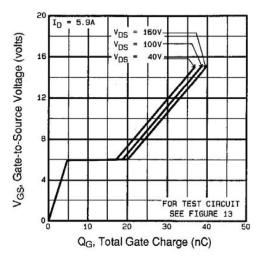


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

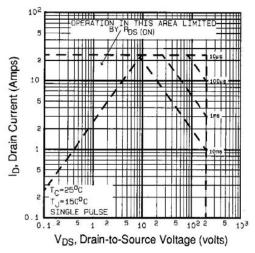


Fig. 8 - Maximum Safe Operating Area





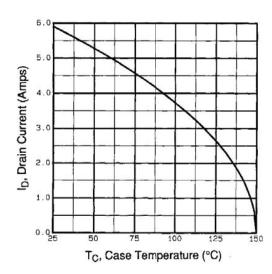


Fig. 9 - Maximum Drain Current vs. Case Temperature

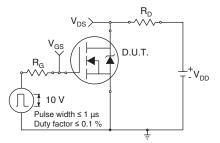


Fig. 10a - Switching Time Test Circuit

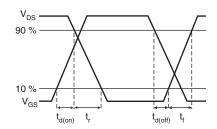


Fig. 10b - Switching Time Waveforms

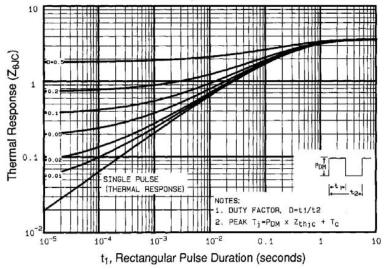


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

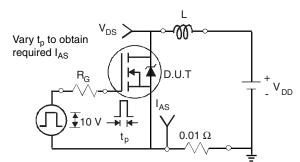


Fig. 12a - Unclamped Inductive Test Circuit

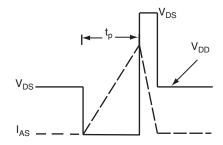


Fig. 12b - Unclamped Inductive Waveforms

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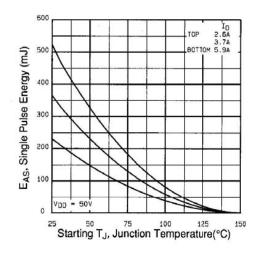


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

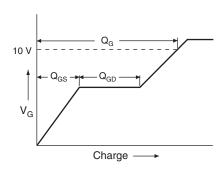


Fig. 13a - Basic Gate Charge Waveform

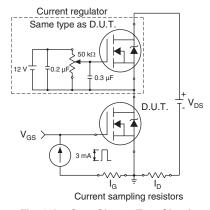
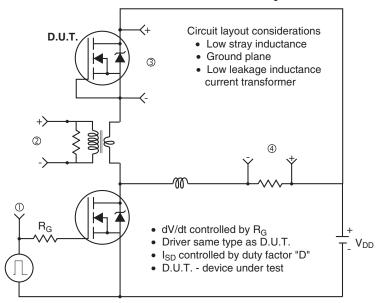
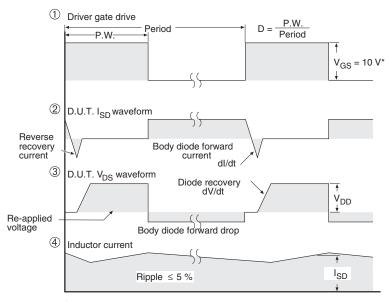


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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